

Notice of References Cited	Application/Control No. 10/748,023	Applicant(s)/Patent Under Reexamination VENKATESWARAN, MUTHIAH	
	Examiner Leonardo Andújar	Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,069,024 A	05-2000	Murakami, Tomoo	438/108
	B	US-6,404,062 B1	06-2002	Taniguchi et al.	257/778
	C	US-6,576,495 B1	06-2003	Jiang et al.	438/108
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.